he broadest family of CMOS and TTL-compatible compact oscillators available, NDK Compact Crystal Clock Oscillators deliver reliable performance in half the space. Ideal for high-density PC boards (such as portable and hand held applications) where space and power are at a premium, these NDK devices are available in a range of frequencies from 28 kHz to 70 MHz. Despite their small size, NDK Compact Crystal Clock Oscillators offer superior resistance to shock, vibration, EMI, and humidity.

1300 SERIES FEATURES

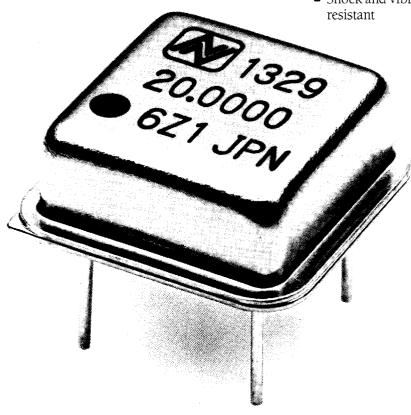
- Broadest range of available frequencies (28 kHz to 70 MHz) speeds design and procurement process
- Choice of TTL, CMOS or dual compatibility for maximum selection
- Compact size perfect for portables
- CMOS technology for low power consumption/ low heat
- Fast rise and fall times (5,7, 10 ns)
- Excellent fan out (2 or 5 TTL gates)
- Sealed, grounded metal case resists EMI and humidity
- Shock and vibration resistant



Headquartered in Tokyo, Japan, NDK is the world's premier manufacturer of synthetic quartz crystal. NDK surpasses all other manufacturers in both quality and quantity of synthetic quartz production. NDK offers the widest range of microprocessor quartz crystals, crystal oscillators, and compact crystal oscillators available. All NDK products are fabricated under the strictest quality controls, and are guaranteed to be free from impurities and defects.

NDK standard products are available through a nationwide network of stocking distributors. NDK also offers custom crystal oscillator fabrication to meet individual needs. For more information on NDK custom services or distribution, write:

NDK America, Inc. 20300 Stevens Creek Blvd. Suite 400 Cupertino, CA 95014-2210



NDK 1300 SERIES SPECIFICATIONS

Available Frequencies

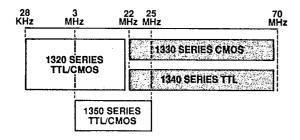


Table 1. 1300 Series Quick-Reference Comparison

Frequency (S Range	Parts Numbers	Output	Power : Consumption '	Rise and Fall Times	VOL Māx. VOH Min.	Duty Cycle %	Fan Out	Standby/ Dual Output
28 kHz- 6.99 MHz	1321- 1328	CMOS/ TTL	5mA typical 10mA maximum	10ns	0:5V V _{DD} -0:5V	45/55	TTL2 LS-TTL10	Standby Only
7 kHz- 22 MHz	1329	CMOS/ TTL	5mA typical 10mA maximum	10ns 🖟	0.5V V _{DD} =0.5V	40/60	TTL2 LS-TTL 10	Standby or Dual
22 MHz– 29.9 MHz	1330- 1332	CMOS Only	13mA typical- 20mA maximum	5ns	0.5V V _{DD} =0.5V	40/60	TTL5 LS-TTL 25	Standby Only
30 MHz- 50.9 MHz	1333– 1337	CMOS Only	17mA typical 30mA maximum	5ns	0.5V V _{DD} -0.5V	40/60	TTL5 LS-TTL 25	Standby Only
51 MHz- 70 MHz	1338- 1339	CMOS Only	22mA typical 40mA maximum	5ns	0.5V V _{DD} =0.5V	40/60	TTL5 LS-TTL25	Standby Only
22 MHz- 29.9 MHz	1340- 1342	TTL Only	13mA typical 20mA maximum	5ns	0.4V 2.4V	40/60	TTL5 LS-TTL25	Standby Only
30 MHz- 50.9 MHz	1343– 1347	TTL .	17mA typical 30mA maximum	5ns	0.4V 2.4V	40/60	TTL5 - LS-TTL25	Standby Only
51 MHz- 70 MHz	1348- 1349	TTL Only	22mA typical - 40mA maximum	5ns	0.5V 2:4V	40/60	TTL5 LS-TTL25	Standby Only
3 MHz- 25 MHz	1351— 1359	CMOS/ TTL	11mA typical 20mA maximum	-: 7ns	0.5V V _{DD} =0.5V	45/55 at ½V _{DD} 40/60 at 1.4V	TTL5 LS/TTL25	Standby Only

Table 2. Output Load and Power Consumption

 $V_{DD} = 5V$

	TTL.		LS-TTL	
Fan out	Resistance (Ω)	Power Consumption (mA)	Resistance (Ω)	Power Consumption (mA)
1	4,000	1,25	20,000	0.25
2	2,000	2:50	10,000	0.50
5	800	6.25	4,000	1.25
10	400	. 12.50	2,000	2.50

SPECIFICATIONS CONTINUED

Table 3. Standby Feature

A feature designed to facilitate board testing, the standby feature permits external digital signals to control oscillator output.

#5 pin output	1320 Series	1330 Series 1340 Series
#1 pin Condition	1350 Series	1360 Series*
H level (+4V min.) or OPEN	Oscillation output	Oscillation output
L level (+ IV max.)	Oscillation stops with the status at an L level.	Oscillation stops with the status at an H level.

*1360 Series is a standby option of the 1350 series.

Dual-Output Option

Available only on Part Number 1329, the dual-output option permits simultaneous output of the original oscillation frequency and the output frequency multiplied by $\frac{1}{2}$ (where n is a positive integer from 1–8) from separate pins of the device.

When the dual-output option is selected, the optional standby feature is not available.

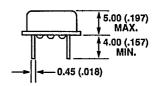
Packaging/Marking

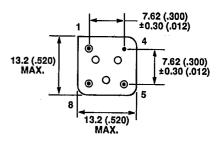
Due to space limitations, output frequency is listed to: 6 digits MHz (ie 14.3181)

5 digits kHz (ie 32.768k)

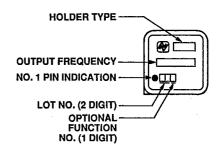
Only the original oscillation frequency is indicated on Part No. 1329 with the dual-output option.





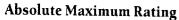


Dimensions in mm (inches).



Pin	Function
I	NC or standby or output (Part 1329) Divided frequency for dual output)
4	GND (Ground to case)
5	Output (Original oscillation frequency)
8	+5VDC

22



▶ Source

-0.5V to +7.0V DC

Voltage (V_{DD})

Storage

Temperature Range

-55°C to +125°C

Operating Conditions

► Source

 $+5.0VDC \pm 0.5V$

Voltage (V_{DD})

▶ Operating

Subject to specifications

Temperature

Range

T_r/T_f Measuring Conditions

► TTL-Compatible

Value between V_OL max. & V_OH min.

(Refer to Measuring Load Conditions,

Figures 1 & 2)

► CMOS-Compatible

Difference between $0.1 \times V_{DD}$ and

 $0.9 \times V_{DD}$ (Refer to Measuring Load

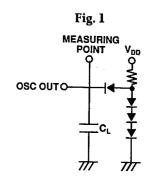
Conditions, Figures 3 & 4)

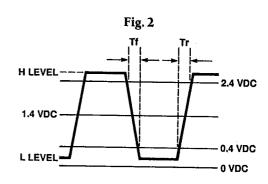
Table 5. Measuring Load Conditions

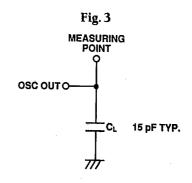
1 TTL = 5 LSTTL

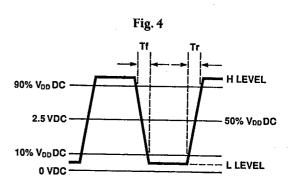
TTL	G _E B _E
1	15pF 4kΩ
2	15pF 2kΩ
5	15pF 800 Ω
10	15pF 400Ω

(Note) CL: includes the stray capacitance of measuring system.









No abnormality after vibration under

STD-202F, Method 211A, Condition A.

Environmental and Mechanical Characteristics

▶ Vibration

MIL-STD-202F, Method 204D, Condition B. Six hour total test time; three orthogonal directions for two hours each. No abnormality after shock test; MIL-▶ Shock STD-202F, Method 213B. 1000 G, 0.5ms, half sine for one time, each in three orthogonal directions. No abnormality under MIL-STD-202F, ► Humidity Method 103B, Condition A. No abnormality under MIL-STD-202F, Soldering Heat Method 210A, Condition B. Thermal Shock No abnormality after execution of 100 cycles. Cycle range and duration: -40°C for 30 minutes, +85°C for 30 minutes. ► Terminal Strength No damage or leakage under MIL-

Handling/Assembly Considerations

The mechanical and electronic properties of crystal products require that they be handled differently than other components.

Bending of Leads Repeated bending or rough handling of leads may break the hermetic seal of the device, leading to performance degradation.

▶ Dropping

NDK Compact Crystal Clock Oscillators have been designed to resist natural physical shocks. However, drops onto hard surfaces may decalibrate these devices. If a device is dropped, remeasure it to confirm accurate calibration before use.

► Static These components, like all CMOS devices, should be kept away from static electricity.

► High Temperature Specifications are not guaranteed if component storage temperature exceeds +125°C for 24 hours.

► Storage and Solderability

The solder-dipped leads of these devices will oxidize over time, negatively impacting solderability. Therefore, we recommend storage of these components be limited to

6 months or less.

ORDERING INFORMATION

When ordering, refer to the tables to select the components and options which meet your frequency specifications.

Please supply the quantity of parts needed, the original oscillating frequency, and the divided frequency (if selecting Part 1329, 7 to 22 MHz, with the dual output option).

To Specify a Product

List part number, frequency stability code, option code and desired frequency. An example is shown below:

1351	В	1	3.0 MHz
(Part	(Frequency	(Output	(Desired
Number)	Stability)	Option)	Frequency)

To Determine Part Number

Use Table 1 to determine the correct series designation and frequency range. The part listed in the example is a 50 series part. Then refer to Table 9 to determine the correct frequency designation. In the example above, a 50 series 3.0 MHz part is designated by 1351. (13 designates the model, 5 designates the series and 1 designates the frequency range.)

To Determine Desired Frequency Stability

Use Table 7. In the example above, the letter B indicates NDK standard is ± 100 ppm over 0°C to 70°C.

To Determine the Desired Output Option

Use Table 8. In the example below, the number 1 indicates NDK standard which has the standby (enable/disable) feature.

Table 7. Operating Temperature/Frequency Stability Code Chart

	Operating	Temperatur	and December the distribution of the control of the	Freque	ency Stability ±100ppm	
	0°C~+70	°C		A	B B	
	-10°C~+	-70°C			G G	25,00
100	-20°C~+	-70°C			M	September 1

Table 8. Standby/Dual Output Option Code Chart

Option	Code	Applicable Parts
Not Connected on Pin 1		$\lim_{\ x\ \to 0} \ A\ _{L^2(\mathbb{R}^n)} \leq \lim_{\ x\ \to 0} \ x\ _{L^2(\mathbb{R}^n)}$
Standby Active		All many and the state of
Dual-Output Active	2	1329

NDK 1300 SERIES

Table 9.

